



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Johannes C. M. VAN DEN BROEK et al.

Serial No.: 10/763,384

Filed: January 26, 2004

For: APPARATUS AND METHOD FOR VISUALLY
INSPECTING SOLDERED JOINTS

Atty. Dkt. No.: 000771.00050

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to his duty of good faith and candor as set forth in 37 C.F.R. § 1.56(a) Applicant submits herewith the references cited on the attached PTO form 1449.

Applicant respectfully requests that the Examiner consider these references in connection with the search of the prior art required by 37 C.F.R. § 1.104.

It is believed that no fee is required to ensure consideration of the cited references by the Examiner. However, if a fee is deemed necessary, the Commissioner is authorized to charge our Deposit Account No. 19-0733.

Date: 2/10/04

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Respectfully submitted,

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Please type a plus sign (+) inside this box → +

PTO/SB/08A (08-00)

Approved for use through 10/31/2002. OMB 0651-0031
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| INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i> | | | | Complete if Known | |
| | | | | Application Number | 10/763,384 |
| | | | | Filing Date | January 26, 2004 |
| | | | | First Named Inventor | J.C.M. VAN DEN BROEK et al. |
| | | | | Group Art Unit | Unknown |
| | | | | Examiner Name | Unknown |
| Sheet | 1 | of | 1 | Attorney Docket Number | 000771.00050 |

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|-----------------------|--|--------------------|--|
| Examiner Signature | | Date Considered | |
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¹EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.